

# DM1400

## Monitoring Burn-In Test System

DM1400 is advanced Package Burn-in Tester, designed for integration of FLASH memory device IC testing capabilities. With its extensive I/O & high speed operating frequency, it provides flexible & extensive environment for users.

- Number of zone : Up to 4zones (option)
- Number of slot : 48 slots, 4 racks, 12slots/rack
- Slot pitch: 40mm pitch
- Temperature : RT~ 150℃
- Temp. Resolution : 0.1℃
- Temp. accuracy :  $\pm 3^{\circ}\text{C}$ (RT ~ +125℃)
- Burn-in Board Size : 450mm× 570mm×1.6mm
- Burn-in Board Density : Depend on power consumption
- Burn-in Board ID : 4X8 Diode Matrix
- Device : SDRAM, DDR, SRAM, GDDR, RDRAM(DA), NOR/NAND-Flash, MCP



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